

# PI6C2409-1H Zero-Delay Clock Buffer

#### Features

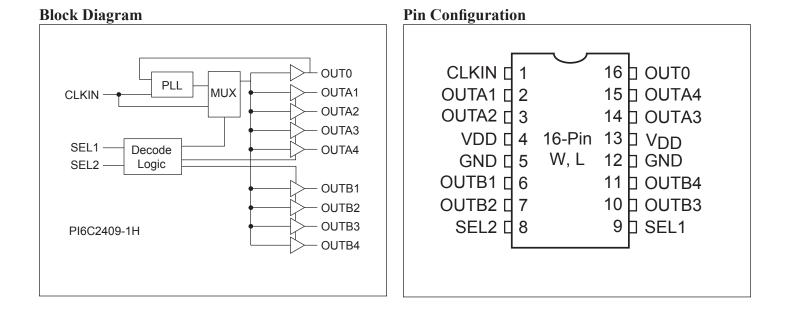
- Maximum rated frequency: 133 MHz
- Low cycle-to-cycle jitter
- Input to output delay, less than 200ps
- Internal feedback allows outputs to be synchronized to the clock input
- Spread spectrum compatible
- Operates at 3.3V V<sub>DD</sub>
- Space-saving Package: (Pb-free & Green available)
  - 16-Pin TSSOP (L)
  - 16-Pin SOIC (W)

#### Description

The PI6C2409-1H is a PLL based, zero-delay buffer, with the ability to distribute nine outputs of up to 133 MHz at 3.3V. All the outputs are distributed from a single clock input CLKIN and output OUT0 performs zero delay by connecting a feedback to PLL.

PI6C2409-1H has two banks of four outputs that can be controlled by the selection inputs, SEL1 & SEL2. It also has a power sparing feature: when input SEL1 is 0 and SEL2 is 1, PLL is turned off and all outputs are referenced from CLKIN. PI6C2409-1H is available in high drive and industrial environment versions.

An internal feedback on OUT0 is used to synchronize the outputs to the input; the relationship between loading of this signal and the outputs determines the input-output delay. PI6C2409-1H are characterized for both commercial and industrial operation



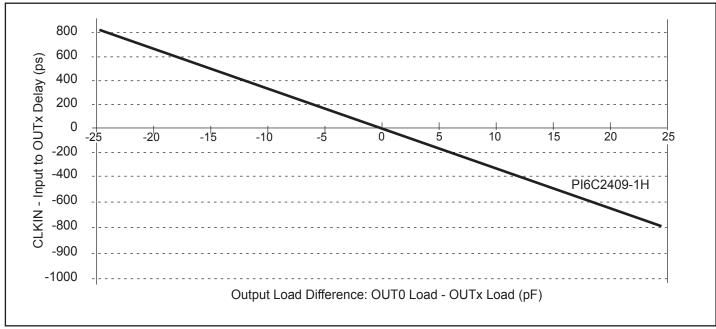
### **Input Select Decoding**

SEL2	SEL1	OUTA [1-4]	OUTB [1-4]	Output Source (OUT0)	PLL
0	0	3-State	3-State	PLL	ON
0	1	PLL	3-State	PLL	ON
1	0	CLKIN	CLKIN	CLKIN	OFF
1	1	PLL	PLL	PLL	ON

### **Pin Description**

Pin	Signal	Description
1	CLKIN	Input clock reference frequency (weak pull-down)
2, 3, 14, 15	OUTA[1-4]	Clock outputs, Bank A
4, 13	VDD	3.3V supply
5, 12	GND	Ground
6, 7, 10 ,11	OUTB[1-4]	Clock outputs, Bank B
8	SEL2	Select input, bit 2 (weak pull-up)
9	SEL1	Select input, bit 1 (weak pull-up)
16	OUT0	Clock Output, internal PLL feedback

#### Zero-Delay and Skew Control CLKIN Input to OUTx Delay vs. Difference in Loading between OUT0 pin and OUTx pins



The relationship between loading of the OUT0 signal and other outputs determines the input-output delay. Zero delay is achieved when all outputs, including feedback, are loaded equally.

### **Maximum Ratings**

(Above which useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	65°C to +150°C
Supply Voltage to Ground Potential	-0.5V to +4.6V
DC Input Voltage	. –0.5V to $V_{DD}$ +0.5V
ESD Protection (Input)	2000 V min (HBM)

**Note:** Stresses greater than those listed under MAXI-MUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

#### **Operating Conditions** ( $V_{CC} = 3.3V \pm 0.3V$ )

Parameter	Description	Min.	Max.	Units
V <sub>DD</sub>	Supply Voltage	3.0	3.6	V
т	Commercial Operating Temperature	0	70	90
TA	Industrial Operating Temperature	-40	85	°C
C	Load Capacitance, below 100 MHz		30	
$C_L$	Load Capacitance, from 100 MHz to 133 MHz	-	15	pF
C <sub>IN</sub>	Input Capacitance	-	7	

#### **DC Electrical Characteristics for Industrial Temperature Devices**

Parameters	Description	Test Conditions	Min.	Max.	Units	
V <sub>IL</sub>	Input LOW Voltage			0.8	v	
$V_{\mathrm{IH}}$	Input HIGH Voltage		2.0		V	
I <sub>IL</sub>	Input LOW Current	$V_{IN} = 0V$		50.0	A	
I <sub>IH</sub>	Input HIGH Current	$V_{IN} = V_{DD}$		125	μA	
VOL	Output LOW Voltage	$I_{OL} = 12mA$		0.4	V	
V <sub>OH</sub>	Output HIGH Voltage	$I_{OH} = -12mA$	2.4		v	
	Bypass, PLL OFF	SEL1 = 0, SEL2 = 1		1.0		
I <sub>DD</sub>		Unloaded outputs 100 MHz, Select inputs at $V_{DD} \mbox{ or GND}$		62	mA	
		Unloaded outputs 66 MHz, CLKIN		44		

Parameters	Name	Test Conditions	Min.	Тур.	Max.	Units
E		30pF load	10.0		100	MII-
Fo	Output Frequency	10pF load	10.0		133	MHz
1	Duty Cycle <sup>(1)</sup>	Measured at $V_{DD}/2$ , F <sub>OUT</sub> = 66.67 MHz	40.0	60.0	0/	
t <sub>DC</sub>	Duty Cycle <sup>(1)</sup>	Measured at $V_{DD}/2V$ , F <sub>OUT</sub> <50MHz	45.0	50	55.0	%
t <sub>R</sub>	Rise Time <sup>(1)</sup>	Measured between 0.8V and 2.0V			1.5	
t <sub>F</sub>	Fall Time <sup>(1)</sup>	Measured between 0.8V and 2.0V			1.5	ns
t <sub>SK(O)</sub>	Output to Output Skew <sup>(1)</sup>	All outputs equally loaded			250	
t <sub>0</sub>	Delay, CLKIN Rising Edge to OUT0 Rising Edge <sup>(1)</sup>	Measured at $V_{DD}/2$		0	±350	ps
t <sub>SK(D)</sub>	Device-to-Device Skew <sup>(1)</sup>	Measured at $V_{DD}/2$ on OUT0 pins of devices		0	700	-
t <sub>SLEW</sub>	Output Slew Rate <sup>(1)</sup>	Measured between 0.8V & 2.0V on –1H device using Test Crt #2	1			V/ns
t <sub>JIT</sub>	Cycle-to-Cycle Jitter <sup>(1)</sup>	Measured at 66.67 MHz, loaded 30pF load			250	ps
t <sub>LOCK</sub>	PLL Lock Time <sup>(1)</sup>	Stable power supply, valid clocks presented on CLKIN pin			1.0	ms

### **AC Electrical Characteristics for Industrial Temperature Devices**

Note:

1. See Switching Waveforms on page 6.

### **DC Electrical Characteristics for Commercial Temperature Devices**

Parameters	Description	Test Conditions	Min.	Max.	Units	
V <sub>IL</sub>	Input LOW Voltage	-	-	0.8	V	
V <sub>IH</sub>	Input HIGH Voltage	-	2.0	-	V	
I <sub>IL</sub>	Input LOW Current	$V_{IN} = 0V$	-	50	A	
I <sub>IH</sub>	Input HIGH Current	$V_{IN} = V_{DD}$	-	125	μA	
V <sub>OL</sub>	Output LOW Voltage	$I_{OL} = 12mA$	-	0.4	v	
V <sub>OH</sub>	Output HIGH Voltage	$I_{OH} = -12mA$	2.4	-	V	
	Bypass, PLL off	SEL1 = 0 SEL2 = 1	-	1.0		
Ipp	Summer Current	Unloaded outputs, 66.67 MHz, Select inputs at V <sub>DD</sub> or GND	-	39	mA	
		Unloaded outputs 100 MHz Select Inputs @ V <sub>DD</sub> or GND	-	54		

Parameters	Description	Test Conditions	Min.	Тур.	Max.	Units
Г	Output Eraguanay	30pF load	10.0		100	MHz
F <sub>O</sub>	Output Frequency	10pF load	10.0		133	MHZ
	Duty Cycle <sup>(1)</sup>	Measured at $V_{DD}/2$ , F <sub>O</sub> = 66.67 MHz	40.0	50	60.0	0 /
t <sub>DC</sub>	Duty Cycle <sup>(1)</sup>	Measured at V <sub>DD</sub> /2V, $F_O < 50 \text{ MHz}$	45.0	- 50	55.0	%
t <sub>R</sub>	Rise Time <sup>(1)</sup>	Magning d hotsing () (2) and () (3)			1.5	
t <sub>F</sub>	Fall Time <sup>(1)</sup>	Measured between 0.8V and 2.0V			1.5	ns
t <sub>SK(O)</sub>	Output to Output Skew <sup>(1)</sup>	All outputs equally loaded			250	
t <sub>0</sub>	Delay, CLKIN Rising Edge to OUT0 Rising Edge <sup>(1)</sup>	Measured at $V_{DD}/2$		0	±350	ps
t <sub>SK(D)</sub>	Device-to-Device Skew <sup>(1)</sup>	Measured at $V_{DD}/2$ on OUT0 pins of devices		0	700	
t <sub>SLEW</sub>	Output Slew Rate <sup>(1)</sup>	Measured between 0.8V & 2.0V on –1H device using Test Crt #2	1			V/ns
t <sub>JIT</sub>	Cycle-to-Cycle Jitter <sup>(1)</sup>	Measured at 66.67 MHz, loaded 30pF load			200	ps
tLOCK	PLL Lock Time <sup>(1)</sup>	Stable power supply, valid clocks presented on CLKIN pin			1.0	ms

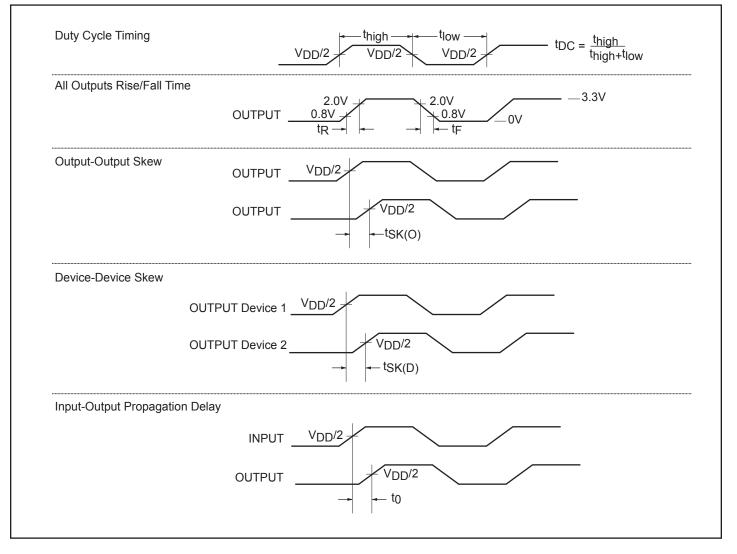
## AC Electrical Characteristics for Commercial Temperature Devices

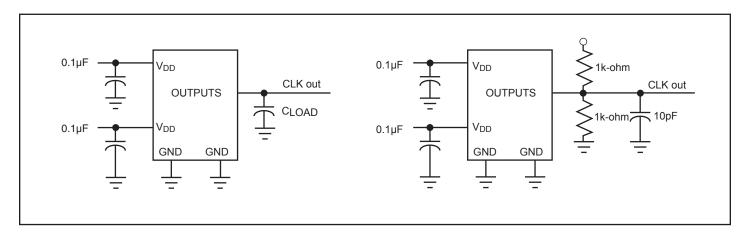
Note:

1. See Switching Waveforms on page 6.

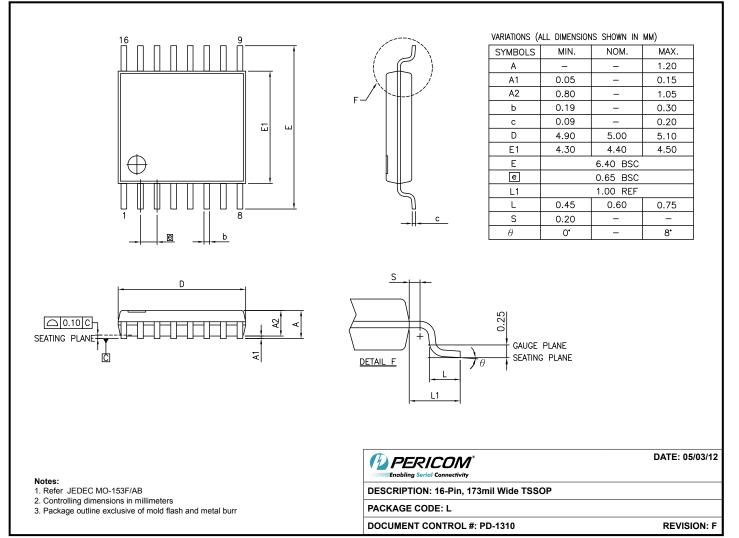


### **Switching Waveforms**



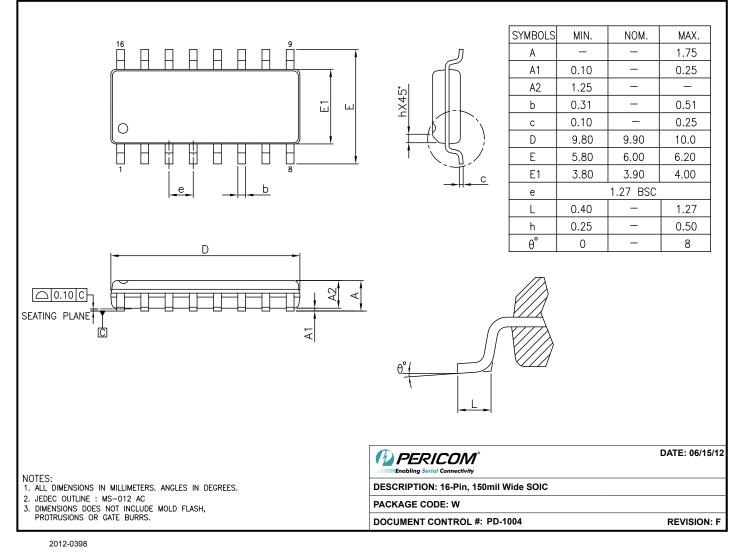


### Packaging Mechanical: 16-Pin TSSOP (L)



12-0372

### Packaging Mechanical: 16-Pin SOIC (W)



#### **Ordering Information**

(TSSOP) (TSSOP), Tape & Reel	Commercial
(TSSOP), Tape & Reel	
	Commercial
(TSSOP)	Industrial
(TSSOP), Tape & Reel	Industrial
(SOIC)	Commercial
(SOIC), Tape & Reel	Commercial
(SOIC)	Industrial
	Industrial
	e (SOIC), Tape & Reel e (SOIC) e (SOIC), Tape & Reel

Notes:

1. Thermal characteristics can be found on the company web site at www.pericom.com/packaging/

2. E = Pb-free and Green

3. Adding an X suffix = Tape/Reel

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